Notice of References Cited

Application/Control No.

O9/941,432

Examiner

Etienne P LeRoux

Applicant(s)/Patent Under Reexamination ARNOLD ET AL.

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,680,622	10-1997	Even, Lindsay Wayne	717/154
	В	US-2003/0016233	01-2003	Charpentier, Frederic Jean-Luc	345/619
	С	US-5,638,498	06-1997	Tyler et al.	358/1.18
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-	s · -		
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.



Notice of References Cited

Application/Control No.	Applicant(s)/Pate	nt Under
09/941,432	Reexamination ARNOLD ET AL.	
Examiner	Art Unit	
Etienne P LeRoux	2171	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0067498	06-2002	Chapman, Edward Neil	358/1.13
	В	US-			
	С	US-			
	D	US-		,	
	Ε	US-		·	
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	US-	1		
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

Notice of References Cited

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